Form PTO-1449 (modified) List of Patents and Publications For Applicant's Information Disclosure Statement (Use several sheets if necessary)			ATTY DO ATTY DO ALL COMMENTS AND EMPRES AND	CKET NO: 5150-55200  APPLICANT: Qi		SERIAL NO: 09/832,505		
			FILING DATE: April 10, 2001			GROUP: 2858		
U.S. PATENT DOCUMENTS								
EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
TW	A1	5,751,149	05/12/1998	Oberg et al.				
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FOREIGN PATENT DOCUMENTS								
EXAM. INITIALS	REF. DES	DOCUMENT	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION. YES/NO	
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				·				
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
Th	A2	A2 Agilent Technologies application Note 1304-2: Time domain Reflectometry Theory, dated 11/2000, 17 pages.						
The	A3	Shie Qian and Dapang Chen, Joint Time-Frequency Analysis Methods and Applications, Chapter 8, 1996, pp. 181-198.						
EXAMINE	R:	T		DATE CONSIDERED:	4/2	28/04		
EXAMINE	R: Initi	ial if citation considered, when the same of the same	nether or not cita red. Include cop	tion is in conformance with May of this form with next comm	PEP 609	; Draw line n to the pat	e through ent owner.	